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Sheet 1 of 1 ATTY DOCKET NO. APPLICATION NO. Form PTO-1449 US Dept. of Commerce 10/591,299 (REV. 1/06) PATENT & TRADEMARK OFFICE 128699 INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary) APPLICANT(S) Susumu NODA et al. **GROUP** FILING DATE August 31, 2006 2883 U.S. PATENT DOCUMENTS Examiner Cite Initials Document Number Date Name No. GUNN, et al. 2003/0068152 A1 4/10/2003 FOREIGN PATENT DOCUMENTS With With Cite Examiner English Country English Initials No. Document Number Date Abstract Translation 2 EP 1 136 853 A1 9/26/2001 Europe OTHER DOCUMENTS Cite Including name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, Examiner journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published. Initials No. WANG, RONGZHOU, et al., "Effects of Shapes and Orientations of Scatterers and Lattice Symmetries on the Photonic Band Gap 3 on Two-Dimensional Photonic Crystals," Journal of Applied Physics, November 1, 2001, pages 4307-4313, vol. 90, no. 9; American Institute of Physics, New York, USA. GERARD, J.M., et al., "Photonic Bandgap of Two-Dimensional Dielectric Crystals," Solid-State Electronics, April 1, 1994, 4 pages 1341-1344, vol. 37, nos. 4-6; Elsevier Science Ltd., Barking, Great Britain. FREZZA, FABRIZIO, et al., "Periodic Defects in 2D-PBG Materials: Full-Wave Analysis and Design," IEEE Transactions on 5 Nanotechnology, September 1, 2003, pages 126-134, vol. 2, no. 3; IEEE Service Center, Piscataway, New Jersey, USA.

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/Kaveh Kianni/ (12/01/2009)